

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/040,173	VAIDYANATHAN ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Chieh M. Fan	2638	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,618,996	10-1986	Rafal et al.	455/46
	B	US-6,148,020	11-2000	Emi, Tetsuichi	375/132
	C	US-6,411,644	06-2002	Myer, Robert Evan	375/132
	D	US-6,654,429	11-2003	Li, Ye	375/316
	E	US-6,853,689	02-2005	Nilsson, Johan	375/267
	F	US-6,912,258	06-2005	Birru, Dagnachew	375/340
	G	US-2002/0044524	04-2002	Laroia et al.	370/203
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.